

FCC TEST REPORT

For

Shantou Chaoyang District Shengtena Electronic Factory

Bluetooth earphone

Model No.: STN-888, STN-780, STN-815, STN-816, K03, K04, K05, K06, V88, V89, V782, V783, V784, V785, DBT28, SBT549, PBT845, PBT865, FBHP760, FBEP285, FBEP592, FBEP340

Prepared For : Shantou Chaoyang District Shengtena Electronic Factory

Address : Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou

City Guangdong Province, China 515159

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited

Address : 1/F, Building D, Sogood Science and Technology Park, Sanwei

community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong,

China.518102

Tel: (86) 755-26066440 Fax: (86) 755-26014772

Report Number : SZAWW180605002-01

Date of Test : Jun. 05~07, 2018

Date of Report : Jun. 07, 2018



Contents

1. General Information	tek	Anbor			od _{ny}	,er	Ano	5
1.1. Client Information	4840	oden.		Yupo	(ootek	ndna	5
1.2. Description of Device (EUT)			otek	Anbore	ν., Ση	<u>.,</u> teY		,o 5
1.3. Auxiliary Equipment Used During Te	st		Yell	do.,,	oter	Aupo	-9/	5
1.3. Auxiliary Equipment Used During Te 1.4. Description of Test Modes	anbo	ie.	YUD.	¥	100tek	Anbo		6
1.5. List of channels		notek	Vupos	P	Vek.		boter	Anb
1.6. Description Of Test Setup	Po	Hotok	dose	ofer	Ann		, otek	8
1.7. Test Equipment List		Vur.	y	"potek	Anbo.			<u>9</u>
1.8 Measurement Uncertainty								v.10
1.9. Description of Test Facility Summary of Test Results	-Notek	dag	Office	Vur		Motek	Anl	10
2. Summary of Test Results	Vu.		potek	Anb			e _K	11
Conducted Emission Test 3.1. Test Standard and Limit	Anbo			(-	upore.	Anv		12
3.1. Test Standard and Limit	24	porc	Anv		botek	Αſ	00.	12
3.2. Test Setup	e ^K	Kupotek	Anb			JK.	Pupote,	12
3.3. Test Procedure		, otel	٠ <u>ه</u>	nbote	An		⁹⁴ 0d _{11,4}	12
3.4. Test Data	por	Pro	184	, nhoter	Ant			12
4. Radiation Spurious Emission and Band Edge 4.1. Test Standard and Limit	a. poter	Anb	·····		te _K	upore	No.	17
4.1. Test Standard and Limit		8 _K	nbore	bite	- Ney	today.	e	17
4.2. Test Setup	br	-otek	Kupote,	Þ.1			otek	17
4.2. Test Setup	An			tek	Anboro	V. V.	- Ne/K	18
4.4. Test Data	e _K	Vupor	br	OKe/K	Robote		Anbe	19
Maximum Peak Output Power Test Test Standard and Limit	otek.	Mupote,	b,			otek	Anbore	26
5.1. Test Standard and Limit	<u></u>		tek	Vupo.			dog	26
5.2. Test Setup	Anbo		hotek	odag	F	7U.p.		26
5.3. Test Procedure	noday	P			potek	Vupo.	P	26
5.4. Test Data		otek	Aupo.		Hotek	امير	ote	26
6. 20DB Occupy Bandwidth Test		wotek.	Pupo		Anv		Mpotek	30
6.1. Test Standard	!							
6.2. Test Setup	oter	Anbe	·	otek	dag		An	30
6.3. Test Procedure	apotek	- Anbo		b11.		upoten	Aup.	30
6.4. Test Data	Pr	k	hoten	Ands		gots	k	30
7 Carrier Frequency Separation Test	AUD							
7.1. Test Standard and Limit	Anb	0.00	b.,		Anboten	Ant		34
7.2. Test Setup	<i>k</i>	photer	And		poteV		upor	34
7.3. Test Procedure	Va/v	potek		por	br.	,eY	boter	34
7.2. Test Setup	o-	br.	e ^K	Aupoten	Anbi			34
8. Number of Hopping Channel Test	apole	And			°, K	por	V. Villa	38
8.1. Test Standard and Limit	. nootel	P.U	po.	br.	Ne/K	Repote	b.)	38
8.2. Test Setup	bo.	to ^K	Pupofer	An			otek	38
8.3. Test Procedure	Aun	Ney	1997	e _K	Aupor	Pri.	Notek	38



	8.4. Test Data	Aupor	br.	tek.	botek	Anbe		notek	Anbore	. 38
9. D	Well Time Test	Anboten	Anb	Ve	wotek	Anbore	An An	, tek	hoda	40
	9.1. Test Standard and	l Limit	tek A	4por	bi.	4 Anho	fer	Anbe		40
	9.2. Test Setup		notek	Pupote.	Anu		,botek	Anbor		40
	9.3. Test Procedure	ore W		botek	Amb	k	Wotek.	odna.	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	40
	9.4. Test Data	anboten.	Aupo		lek b	upore	Vur		potek	. 40
10.	100kHz Bandwidth of	Frequency B	and Edge I	Requiremen	nt\	Motek	Anbo		Hotek	44
	10.1. Test Standard ar	nd Limit	000	ren Ar		- otek	104	3010	Vu.	44
	10.2. Test Setup	Anb		botek.	Anbore	<i>b</i> ₀ .		Kupotek	Anbo	44
	10.3. Test Procedure	k Aupo	, b	Yayou	anbote.	Anbs		, olek	10.4	44
	10.4. Test Data	otek No	boter	Anu		tek Ar	por	by.		. 44
11.	Antenna Requirement		Mootek.	Vupo.		-dek	Anboter	Anb		49
	11.1. Test Standard ar	nd Requireme	ent	, nbot	Α'		pats	³ K	por	49
	11.2. Antenna Connec	eted Construc	ction		potek	Anbor K	b.r	4940.	anboten	49
APF	PENDIX I TEST SE	TUP PHOTO	GRAPH		work.	Ropote.	Am	······	ote	50
APF	PENDIX II EXTERN	NAL PHOTO	GRAPH	pore.	Anu Tok		e _{/r}	Yupor.		. 52
APF	PENDIX III INTERN	NAL PHOTO	GRAPH	botek	Aupo	b.,	18K	aboter	And	56



TEST REPORT

Applicant : Shantou Chaoyang District Shengtena Electronic Factory

Manufacturer : Shantou Chaoyang District Shengtena Electronic Factory

Product Name : Bluetooth earphone

Model No. : STN-888, STN-780, STN-815, STN-816, K03, K04, K05, K06, V88, V89, V782.

V783, V784, V785, DBT28, SBT549, PBT845, PBT865, FBHP760, FBEP285,

FBEP592, FBEP340

Trade Mark : N.A.

Rating(s) : Input: DC 5V, 100mA (with DC 3.7V, 70 mAh Battery inside)

Test Standard(s) : FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) : **ANSI C63.10: 2013**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test				rok	un. 03~07, 2018		
	Anbotek	Anbore					
	Anbo		Anbore	0	bian larg		
	6 Anb	WBOTE S	No te V		J by A		
Prepared by		F. C.	Anv		otek Anbo	by.	do 49
	orce Control	Ambotek	pote Anbo	(Eng	gineer / Oliay Yang	g)	
		THE		0.0	And Cha	wote.	
	Am	WFICD	August 1	4 ml	win Is	12	
			aboten	ATTO	To lone	Anb ite	
Reviewer			A. rek	200	br	-otek	Vupore
Keviewei				(Sup	ervisor / Calvin Li	u)	
					hotek Anbore		
				botek - P	7 .xx 1 x		
					lon dre		
		ner sobotek			love Che	W. O.	
Approved & A	uthorized Sign	ner Anbo	A. otek	anbote.	Ann	hotek	Anbor
			And	(Ma	anager / Tom Chen	Am	botek
				Andivid	inuger / Tom Chen	, upore	



1. General Information

1.1. Client Information

Applicant	:	Shantou Chaoyang District Shengtena Electronic Factory
Address	:	Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou City Guangdong Province, China 515159
Manufacturer	:	Shantou Chaoyang District Shengtena Electronic Factory
Address	:	Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou City Guangdong Province, China 515159

1.2. Description of Device (EUT)

Product Name	:	Bluetooth earphone	Anbotek Anbotek Anbotek Anbotek							
Model No.	:	101 M	STN-888, STN-780, STN-815, STN-816, K03, K04, K05, K06, V88, V89, V782,							
c		V783, V784, V785, DBT28, SBT549, PBT845, PBT865, FBHP760, FBEP285, FBEP592, FBEP340								
		(Note: All samples are the same 6 "STN-888" for test only.)	except the colour and appearance, so we prepare							
Trade Mark	:	N.A.	Anbotek Anbotek Anbotek Anbotek							
Test Power Suppl	ly :	AC 240V, 60Hz for adapter/ AC DC 3.7V Battery inside	AC 240V, 60Hz for adapter/ AC 120V, 60Hz for adapter/ DC 3.7V Battery inside							
		Operation Frequency:	2402MHz~2480MHz							
S		Transfer Rate:	1/2 Mbits/s							
Product		Number of Channel:	79 Channels							
Description		Modulation Type:	GFSK, π/4-DQPSK							
		Antenna Type:	PCB Antenna							
		Antenna Gain(Peak):	0 dBi							

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

AO.		- MP			D.1.		LD. C
N/A	Anbo.	p. bot	ek Anbore	Anto	tek ont	otek Ani	2010 N



1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode		Description						
Mode 1	rek VIII.	botek	Anbotek	Yupo of	CH00	botek	Anbore.	Ans
Mode 2	or b	- abotek	Anboten	Anbo	СН39	Anbotek	Anbore	Vu.
Mode 3	nbo	A nbotel	Anbote	-K Mu	CH78	Anbotek	Anbore	FEK
Mode 4	Anbountek	, vupe	stek Anbi	Keeping 7	ΓX+ Char	ging Mode	tek Anb	-tek P

For Conducted Emission							
Final Test Mode Description							
Mode 4	Keeping TX+ Charging Mode	Anbo					

For Radiated Emission										
F	inal Test Mo	de			Description	n				
Anbore	Mode 1	otek Ar	poter A	Ipo Stek	CH00	ole Vu	hotek	Anbotek		
Aupo	Mode 2	nbotek	Anboter	Anb	СН39	Anbote	An	Anbo		
Ken Ar	Mode 3	Anbotek	Anbote.	Aur	CH78	Anbot	Ai.	k Ar		
poter	Mode 4	Anbotek	Anbore	Kee	ping TX+ Charg	ging Mode	sk up	otek		

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
- (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.



1.5. List of channels

Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.
	(MHz)		(MHz)		(MHz)		(MHz)		(MHz)
00	2402	Anb 17	2419	34	2436	51	2453	68	2470
01	2403	18otek	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53 oten	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
Vel 07 AT	2409	24	2426	41 🗝	2443	58	2460	75	2477
08	2410	25	2427	42 p	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote ^k 77	2479
Marie 10	2412	27 📉	2429	44	2446	61 mbo	2463	78	2480
phPoto.	2413	28	2430	45	2447	62	2464		
12,000	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47,000	2449	64	2466		
14	2416	31	2433	48	2450	65	2467	5 nnb	oten A
15 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67 of	2469		

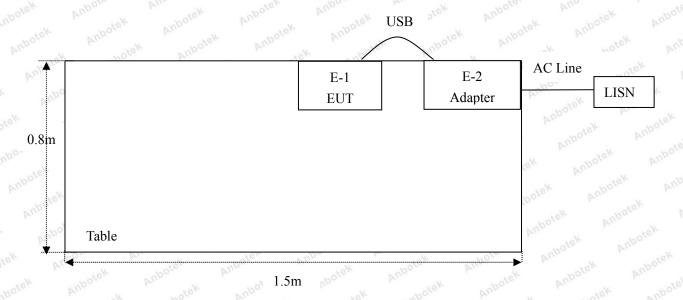
Note:

- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

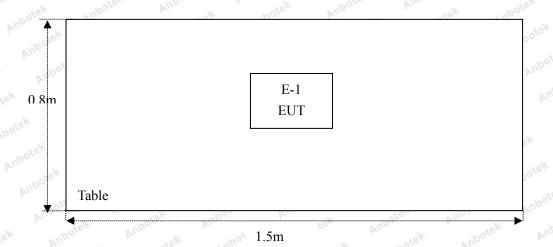


1.6. Description Of Test Setup

CEo



RE





1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval	
otek 1. Inbotek	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year	
2,00	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year	
3. №	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year	
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year	
5.	Spectrum Analysis	Agilent	N9038A	MY53227295	Nov. 17, 2017	1 Year	
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 17, 2017	1 Year	
17. hot	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year	
8.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year	
9.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year	
10.	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year	
MT.	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year	
12.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year	
13.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A	
14.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year	
15.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year	
16.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year	
17.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year	
18.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year	
19.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year	
20.	DC Power Supply	Anbote LW Anbo	TPR-6410D	349315	Nov. 01, 2017	1 Year	
21.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80B	ZJ-17042804	Nov. 01, 2017	1 Year	



1.8. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 3.9 dB (Horizontal)	potek Anbore An
		Ur = 3.8 dB (Vertical)	Anbotek Anbot Air
		Anbotek Anbote An-	Anbotek Anbo.
Conduction Uncertainty	:	Uc = 3.4 dB	Anbotek Anbo

1.9. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

All Emissions tests were performed at Shenzhen Anbotek Compliance Laboratory Limited. at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Test Item	Result
Antenna Requirement	PASS
Conducted Emission	PASS
Spurious Emission	PASS
Conducted Peak Output Power	PASS
20dB Occupied Bandwidth	PASS
Carrier Frequencies Separation	PASS
Hopping Channel Number	PASS
Dwell Time	PASS
Band Edge	PASS
	Antenna Requirement Conducted Emission Spurious Emission Conducted Peak Output Power 20dB Occupied Bandwidth Carrier Frequencies Separation Hopping Channel Number Dwell Time



3. Conducted Emission Test

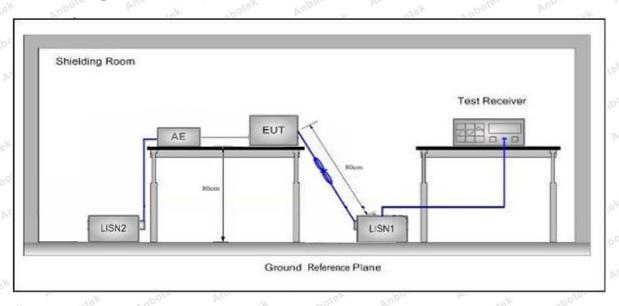
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.20	7 Anbore Am botek	Anbotek Anbo stek				
	F	Maximum RF Line Voltage (dBuV)					
	Frequency	Quasi-peak Level	Average Level				
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *				
	500kHz~5MHz	56	46				
	5MHz~30MHz	60	50				

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages.

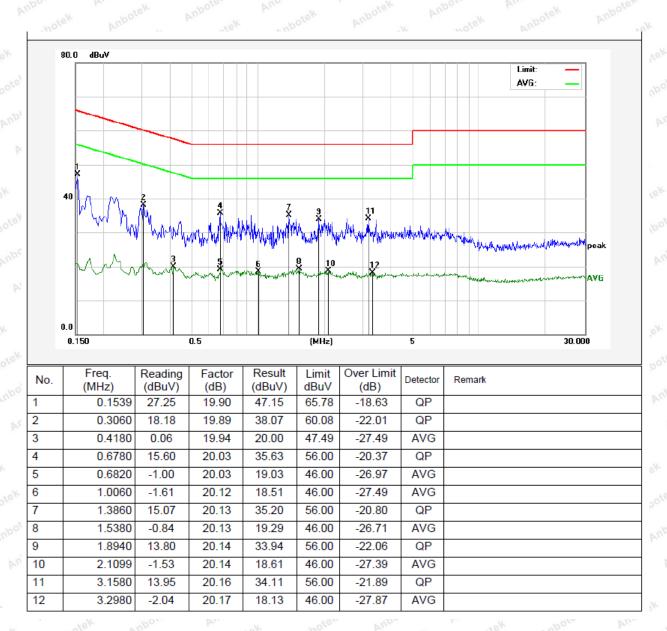


Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.: 25.4°C Hum.: 54%



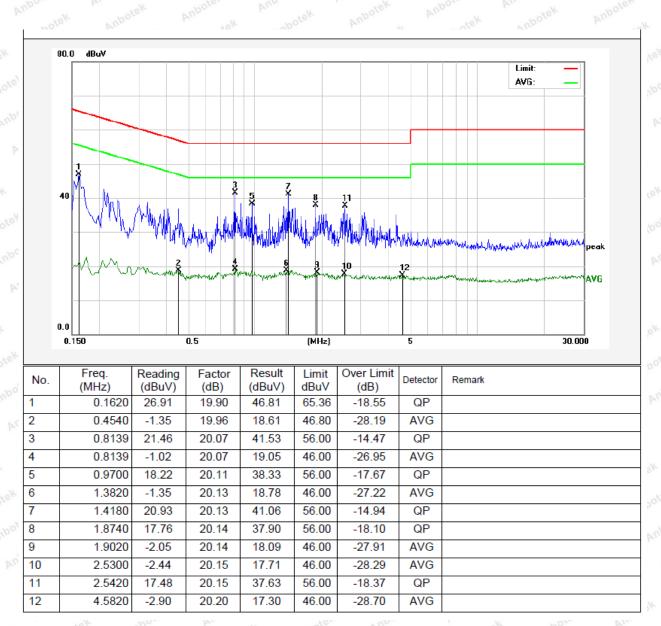


Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.: 25.4℃ Hum.: 54%



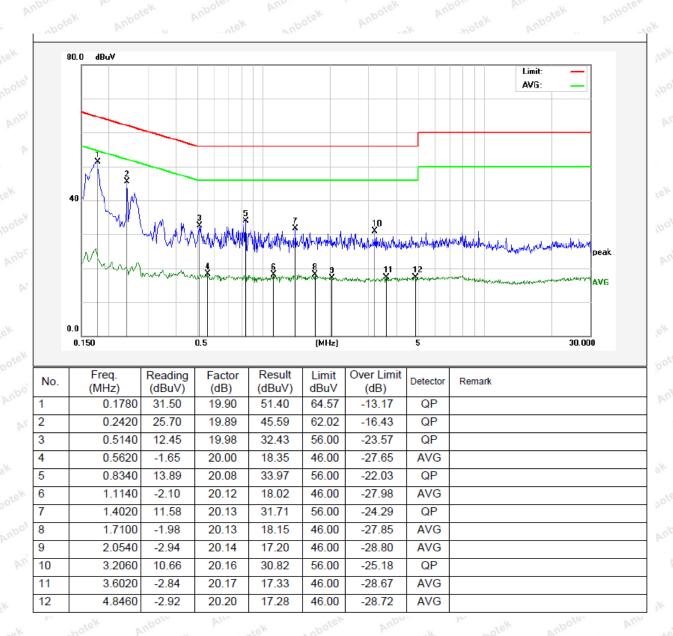


Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Live Line

Tem.: 25.4°C Hum.: 54%



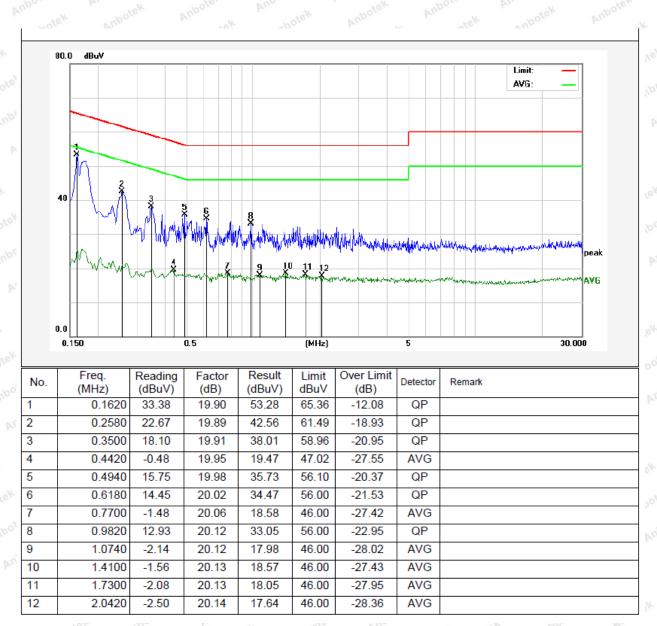


Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Neutral Line

Tem.: 25.4°C Hum.: 54%





4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	09 and 15.205	Ans	Anbotek I	Tupo, Tek
P	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	obotek - Anbo	or bur	300
2	0.490MHz-1.705MHz	24000/F(kHz)	Aupotek A	pore Aug	notel 30 Anb
9	1.705MHz-30MHz	30	Anbatek	Anbore P	30
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	3
	88MHz~216MHz	150	43.5	Quasi-peak	3 _{botek}
	216MHz~960MHz	200	46.0	Quasi-peak	cek 3 nbotek
	960MHz~1000MHz	500	54.0	Quasi-peak	atek 3 nobo
¢	Above 1000MII-	500	54.0	Average	3
	Above 1000MHz	botek - Anbot	74.0	Peak	Ambo 3

Remark:

- (1)The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

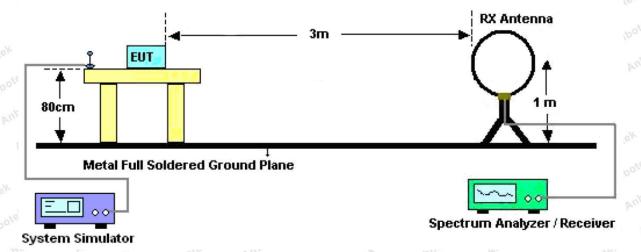


Figure 1. Below 30MHz



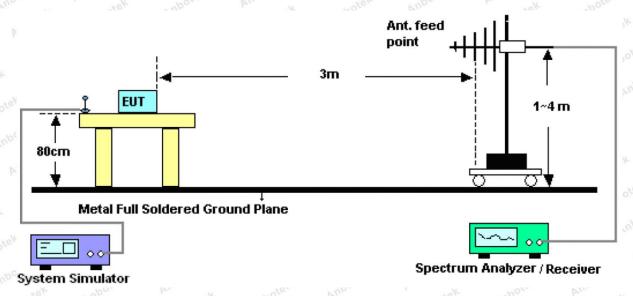


Figure 2. 30MHz to 1GHz

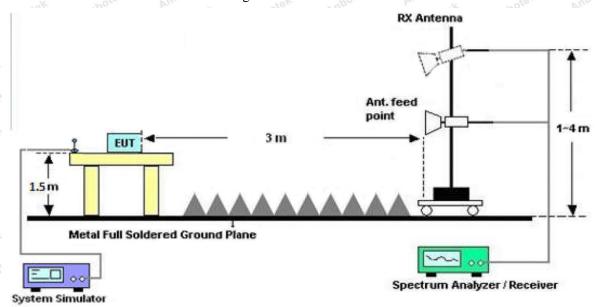


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying



aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW = 300kHz, Detector = Quasi-Peak, Trace mode = Max hold, Sweep- auto couple.

For above 1GHz,Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, π /4QPSK modulation, and found the GFSK modulation Middle channel which is the worst case, only the worst case is recorded in the report

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

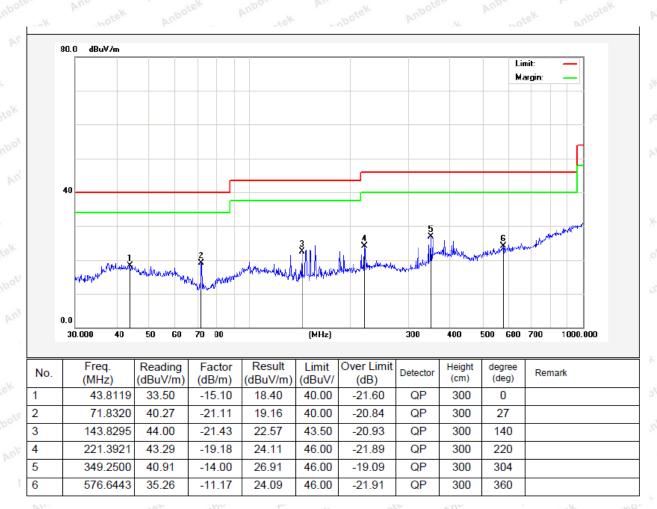


Test Results (30~1000MHz)

Job No.: SZAWW180605002-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Horizontal



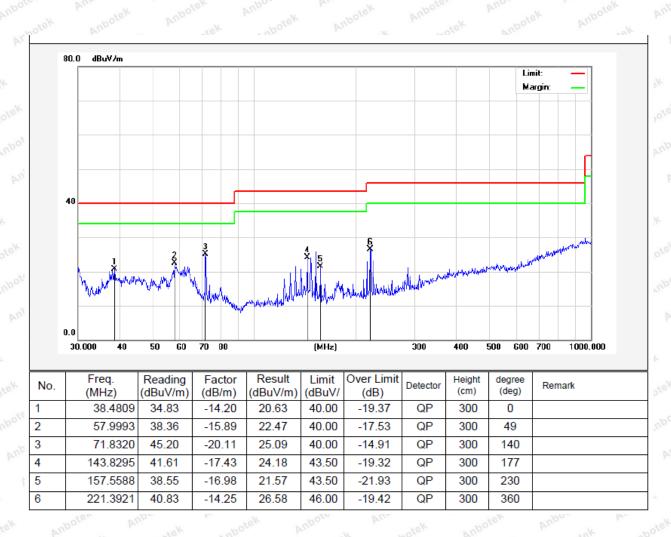


Test Results (30~1000MHz)

Job No.: SZAWW180605002-01 Temp.(°C)/Hum.(%RH): 23.2°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Vertical





Test Results (1GHz-25GHz)

Test Mode: (Test				
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	38.83	34.04	6.58	34.09	45.36	74.00	-28.64	poteV
7206.00	32.84	37.11	7.73	34.50	43.18	74.00	-30.82	v V
9608.00	32.37	39.31	9.23	34.79	46.12	74.00	-27.88	V
12010.00	*	tek	abotek p	upor	An spotek	74.00	Aupo	V
14412.00	* And	ntek .	nbotek	Aupoter	Aur	74.00	Anbor	e ^K V
4804.00	43.42	34.04	6.58	34.09	49.95	74.00	-24.05	H
7206.00	34.73	37.11	7.73	34.50	45.07	74.00	-28.93	H
9608.00	31.93	39.31	9.23	34.79	45.68	74.00	-28.32	Anbou
12010.00	* Anbote	Anbo	18K	abotek	Anboten	74.00	Anbotek	PΉ
14412.00	cek * Amb	yek by	100r B	abotek	Anboten	74.00	anbotek	Н
			A	verage Value	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol
4804.00	27.35	34.04	6.58	34.09	33.88	54.00	-20.12	V
7206.00	21.35	37.11	7.73	34.50	31.69	54.00	-22.31	V
9608.00	20.34	39.31	9.23	34.79	34.09	54.00	-19.91	V
12010.00	potek * A	lpo.	anbotek	Anbores	r Pup	54.00	Anbor	V
14412.00	Anbote*	Anbo	A hotek	Anbote	Amp	54.00	lek Ant	V
4804.00	31.75	34.04	6.58	34.09	38.28	54.00	-15.72	Yupole
7206.00	23.63	37.11	7.73	34.50	33.97	54.00	-20.03	μΉ
9608.00	20.19	39.31	9.23	34.79	33.94	54.00	-20.06	H
12010.00	stek *	potek	Anboth	Andotek	Anbotek	54.00	phote	[⊮] Н
14412.00	*	hotek	Anbote	Pun.	k abote	54.00	V P.	ote ^K H



Test Results (1GHz-25GHz)

Test Mode: 0	CH39			Test	channel: Midd	le		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	37.52	34.38	6.69	34.09	44.50	74.00	-29.50	boteV
7323.00	31.97	37.22	7.78	34.53	42.44	74.00	-31.56	Vek
9764.00	31.59	39.46	9.35	34.80	45.60	74.00	-28.40	V
12205.00	*	tek	abotek P	upoto	An.	74.00	Aupo	V
14646.00	* And	ntek .	nbotek	Aupoten	Aur	74.00	Anbo	v V
4882.00	41.85	34.38	6.69	34.09	48.83	74.00	-25.17	H
7323.00	33.74	37.22	7.78	34.53	44.21	74.00	-29.79	H
9764.00	31.04	39.46	9.35	34.80	45.05	74.00	-28.95	Anboto H
12205.00	* Anbote	Anbo	rek Vi	botek	Anboten	74.00	Anbotek	PH
14646.00	cek * Amb	yek by	100r B	abotek	Anboten	74.00	nbotek	H
		**	A	verage Value	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	26.31	34.38	6.69	34.09	33.29	54.00	-20.71	V
7323.00	20.64	37.22	7.78	34.53	31.11	54.00	-22.89	V
9764.00	19.71	39.46	9.35	34.80	33.72	54.00	-20.28	V
12205.00	potek * A	lpo,	potek .	Anboten	Anbo	54.00	Anbot	V
14646.00	Anbotsk	Aupor	An botek	Anbote	Ambo	54.00	lek Ant	V
4882.00	30.56	34.38	6.69	34.09	37.54	54.00	-16.46	Yupofer.
7323.00	22.83	37.22	7.78	34.53	33.30	54.00	-20.70	P.H.
9764.00	19.45	39.46	9.35	34.80	33.46	54.00	-20.54	Ηn
12205.00	otek *	botek	Aupore.	Andabotek	Anbotek	54.00	abote	Н
14646.00	*	nbotek	Aupore	Anv	Anbote	54.00	5/4 - 10	ote ^K H



Test Results (1GHz-25GHz)

Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	35.86	34.72	6.79	34.09	43.28	74.00	-30.72	boteV
7440.00	30.87	37.34	7.82	34.57	41.46	74.00	-32.54	Vek
9920.00	30.61	39.62	9.46	34.81	44.88	74.00	-29.12	V
12400.00	*	stek	abotek p	upoto	An. Potek	74.00	Aupor	V
14880.00	* Anti	Nek	Motek	Aupoter	Au., Potek	74.00	Pupor	V V
4960.00	39.85	34.72	6.79	34.09	47.27	74.00	-26.73	H
7440.00	32.50	37.34	7.82	34.57	43.09	74.00	-30.91	H
9920.00	29.90	39.62	9.46	34.81	44.17	74.00	-29.83	Anbox
12400.00	* Anbote	Anbo	16K	obotek	Aupoto	74.00	anbotek	H4
14880.00	cek * Anb	View Vi	100 P	abotek	Anboten	74.00	Anbotek	H×
			Α	verage Value	e	0,0		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	24.99	34.72	6.79	34.09	32.41	54.00	-21.59	V
7440.00	19.75	37.34	7.82	34.57	30.34	54.00	-23.66	V
9920.00	18.91	39.62	9.46	34.81	33.18	54.00	-20.82	V
12400.00	poter * A	lpo.	abotek.	Anbores	Aug of e	54.00	Anbot	V
14880.00	Anbotak	Anbor	An abotek	Anbote	Ambo	54.00	lek but	V
4960.00	29.06	34.72	6.79	34.09	36.48	54.00	-17.52	Yupole H
7440.00	21.83	37.34	7.82	34.57	32.42	54.00	-21.58	MA
9920.00	18.53	39.62	9.46	34.81	32.80	54.00	-21.20	Ηn
12400.00	Yek *	potek	Aupot	Andotek	Anbotek	54.00	phote	Н
14880.00	*	botek	Anboten	Ann	k nbote	54.00	ok ~ ~	ote ^K H

Remark:

- 1. During the test, pre-scan the GFSK, π /4QPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.



Radiated Band Edge:

Test Mode: 0	21100			Test	channel: Lowe			
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	45.79	29.15	3.41	34.01	44.34	74.00	-29.66	Hek
2400.00	62.99	29.16	3.43	34.01	61.57	74.00	-12.43	Hot
2390.00	46.61	29.15	3.41	34.01	45.16	74.00	-28.84	V
2400.00	65.34	29.16	3.43	34.01	63.92	74.00	-10.08	V
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	35.68	29.15	3.41	34.01	34.23	54.00	-19.77	AHO!
2400.00	47.09	29.16	3.43	34.01	45.67	54.00	-8.33	Hant
2390.00	35.83	29.15	3.41	34.01	34.38	54.00	-19.62	v V
2400.00	49.02	29.16	3.43	34.01	47.60	54.00	-6.40	oteVV

Test Mode: 0	CH78			Test	channel: High	est		
			:	Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	48.24	29.28	3.53	34.03	47.02	74.00	-26.98	HoH.
2500.00	46.86	29.30	3.56	34.03	45.69	74.00	-28.31	Hotek
2483.50	49.57	29.28	3.53	34.03	48.35	74.00	-25.65	V
2500.00	48.13	29.30	3.56	34.03	46.96	74.00	-27.04	V
			A	verage Valu	e	183		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	38.54	29.28	3.53	34.03	37.32	54.00	-16.68	AnH ten
2500.00	36.13	29.30	3.56	34.03	34.96	54.00	-19.04	Habo
2483.50	40.00	29.28	3.53	34.03	38.78	54.00	-15.22	V
2500.00	36.29	29.30	3.56	34.03	35.12	54.00	-18.88	tek V

Remark:

- 1. During the test, pre-scan the GFSK, π /4QPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor



5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	247 (b)(3)	Andwotek	Anbotek	Anbor	VI.
Test Limit	125mW	a nbotek	Anbote.	k hotek	Anbotek	Anbor	ik bi

5.2. Test Setup



5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

 $VBW \ge RBW$

Sweep = auto

Detector function = peak

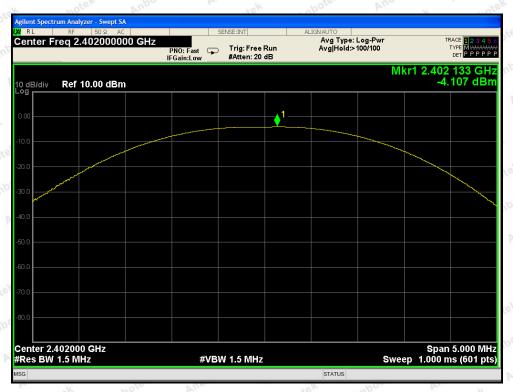
 $Trace = \max hold$

5.4. Test Data

Test Item	:	Max. peak output power	Test Mode :	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature :	24°C
Test Result	:	PASS	Humidity :	55%RH

Chanr	nel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results	Modulation	
Anboter	2402	-4.107	20.96	PASS	BDR	
Anbo	2441	-3.802	20.96	PASS	BDR	
P.	2480	-3.229	20.96	PASS	BDR	
rek	2402	-3.032	20.96	PASS	EDR	
hotek	2441	-2.734	20.96	PASS	EDR	
Anbotek	2480	-2.137	20.96	PASS	EDR	



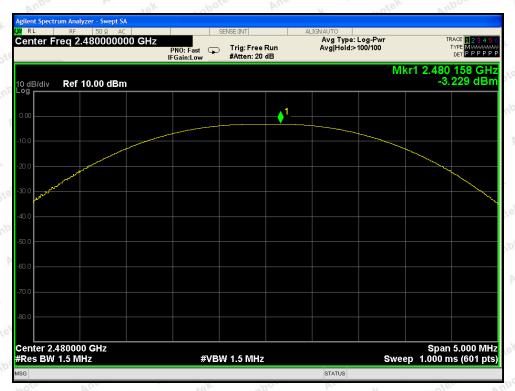


Test Mode: BDR----Low

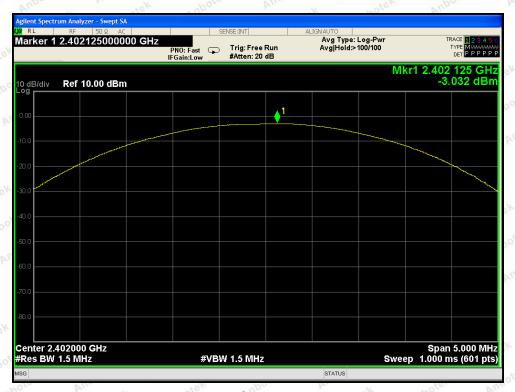


Test Mode: BDR---Middle





Test Mode: BDR---High

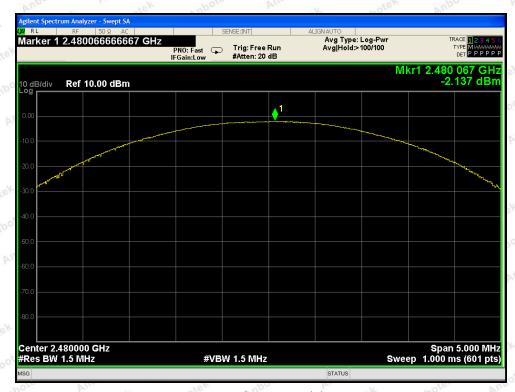


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

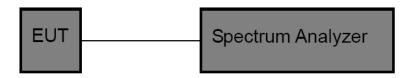


6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Test Standard FCC Part15 C Section 15.247 (a)(1)	Annabotek	Anbotek	Anbo.	r br
--	-----------	---------	-------	------

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

Test Item :	20dB BW	Test Mode	:	CH Low ~ CH High
-------------	---------	-----------	---	------------------

Test Voltage : DC 3.7V Battery inside Temperature : 24°C

Test Result : PASS Humidity : 55%RH

Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode
Low	2402	909.8	BDR
Middle	2441	885.7	BDR
High	2480	886.8	BDR
Low	2402	1209.0	EDR
Middle	2441	1211.0	EDR
High	2480	1210.0	EDR

Remark: The EDR was tested on $\pi/4$ DQPSK modes, the data of $(\pi/4$ DQPSK) is attached in the following pages.





Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High

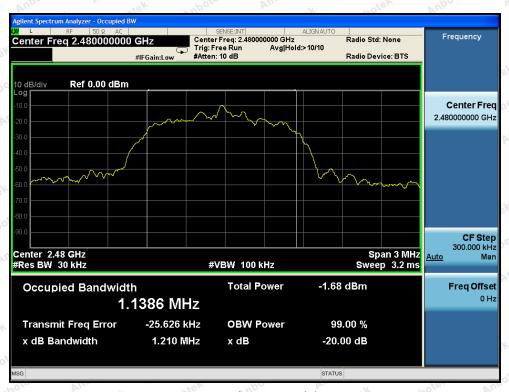


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

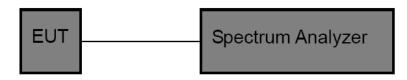


7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

0	Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo	P
	Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anboatek	P

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	24℃
Test Result	:	PASS	Humidity	:	55%RH

107	20	VI. VII.	20.	WO. Dr.
Channel	Frequency	Separation Read	Limit	Modulation Mode
Chamiei	(MHz)	Value (kHz)	(kHz)	Wiodulation Wiode
Low	2402	1000	909.8	BDR
Middle	2441	1000	885.7	BDR
High	2480	1000	886.8	BDR
Low	2402	1000	806.0	EDR
Middle	2441	1000	807.3	EDR
High	2480	1000	806.7	EDR

Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. Remark: The EDR was tested on $\pi/4$ DQPSK modes, the data of $(\pi/4$ DQPSK) is attached in the following pages.





Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

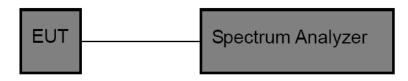


8. Number of Hopping Channel Test

8.1. Test Standard and Limit

d'o	Test Standard	FCC Part15 C S	Section 15.2	247 (a)(1)	Anshotek	Anbotek	Anbo	p.
	Test Limit	>15 channels	Anbotek	Anboro	An. botek	Anbotek	Anbo	F

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

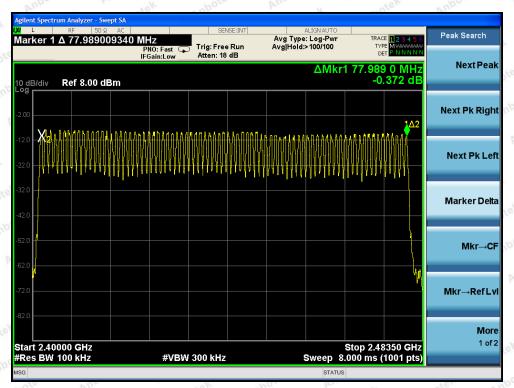
- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

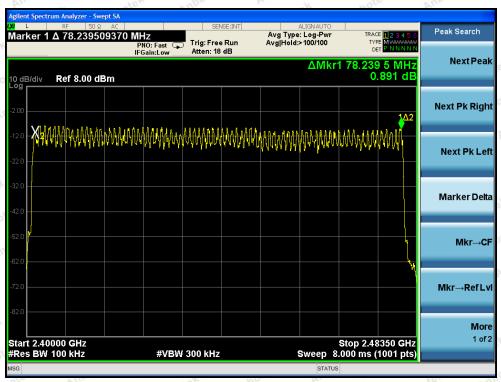
Test Item :	Number of Hopping Frequency	Test Mode :	CH Low ~ CH High
Test Voltage :	DC 3.7V Battery inside	Temperature :	24°C
Test Result :	PASS	Humidity :	55%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel	
2402-2480MHz	Ambot Ambot	>15 nboten	





BDR Mode



EDR Mode

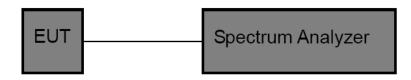


9. Dwell Time Test

9.1. Test Standard and Limit

je.	Test Standard	FCC Part15	C Section 15.2	247 (a)(1)	And	Anbotek	Anbo	P
	Test Limit	0.4 sec	Anbotek	Anboro	Air	Anbotek	Anbo	

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

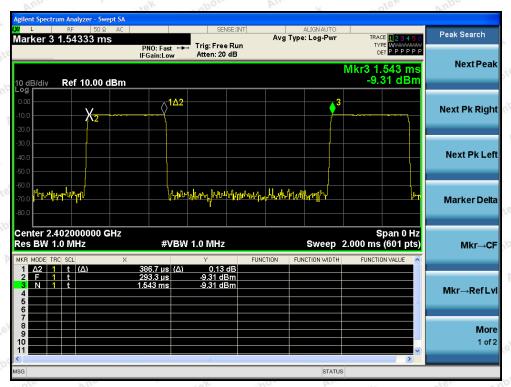
9.4. Test Data

Test Item	:	Time of Occupancy	Test Mode :	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature :	24°C
Test Result	:	PASS	Humidity :	55%RH

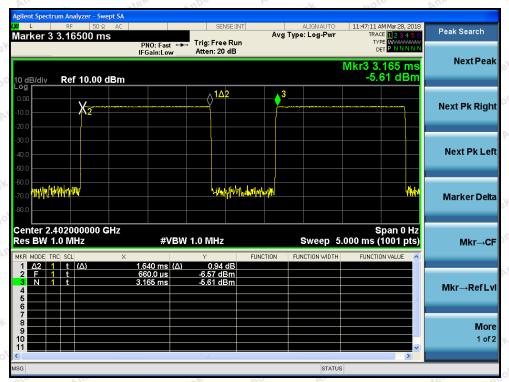
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.3867	time slot length *1600/2 /79 * 31.6	123.74	0.4	BDR
DH3	1.640	time slot length *1600/4 /79 * 31.6	262.40	0.4	BDR
DH5	2.893	time slot length *1600/6 /79 * 31.6	308.59	0.4	BDR
2DH1	0.400	time slot length *1600/2 /79 * 31.6	128.00	0.4	EDR
2DH3	1.642	time slot length *1600/4 /79 * 31.6	262.72	0.4	EDR
2DH5	2.907	time slot length *1600/6 /79 * 31.6	310.08	0.4	EDR

Remark: The EDR was tested on $\pi/4$ DQPSK modes, the data of ($\pi/4$ DQPSK) is attached in the following pages.



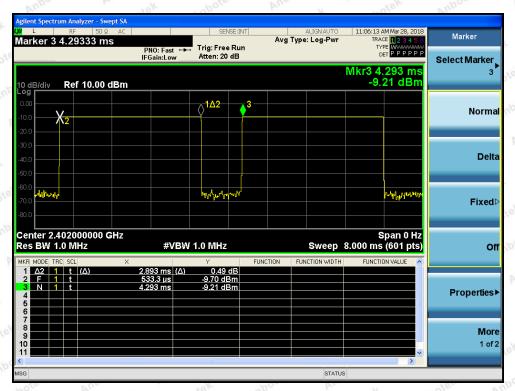


Test Mode: BDR---DH1

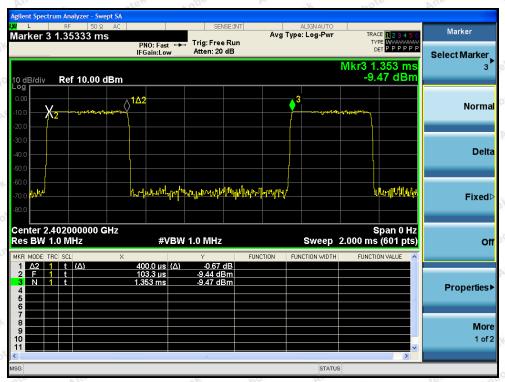


Test Mode: BDR---DH3



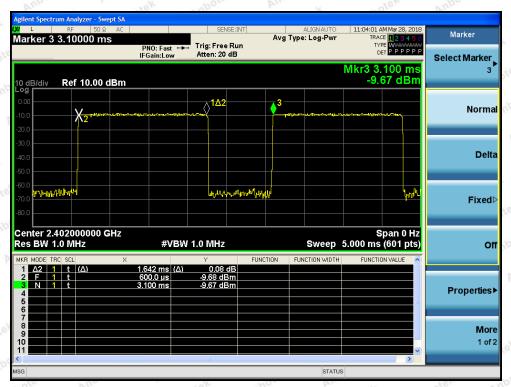


Test Mode: BDR—DH5

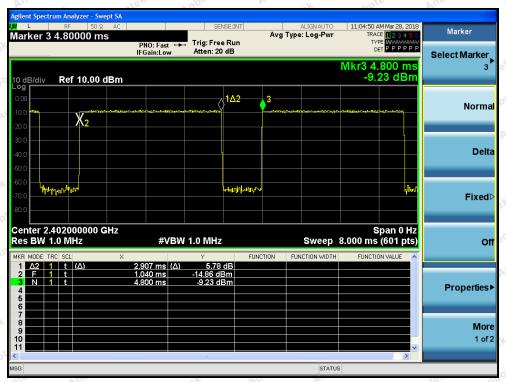


Test Mode: EDR---2DH1





Test Mode: EDR---2DH3



Test Mode: EDR—2DH5



10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.

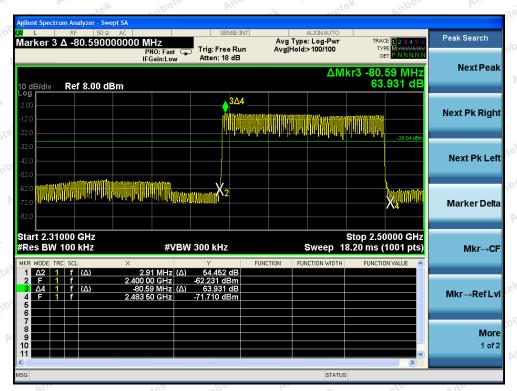
10.4. Test Data

Test Item :	Band edge	Test Mode :	CH Low ~ CH High
Test Voltage :	DC 3.7V Battery inside	Temperature :	24℃
Test Result :	PASS	Humidity :	55%RH

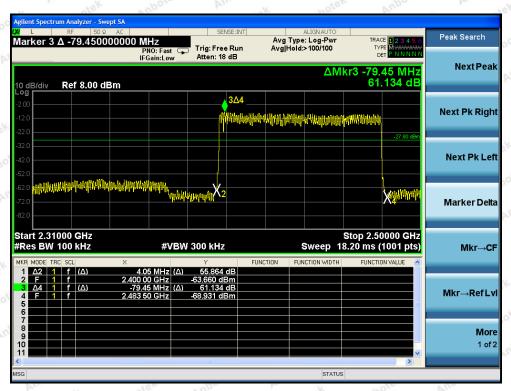
Remark: The EDR was tested on $\pi/4$ DQPSK modes, the data of ($\pi/4$ DQPSK) is attached in the following pages.



For Hopping Mode



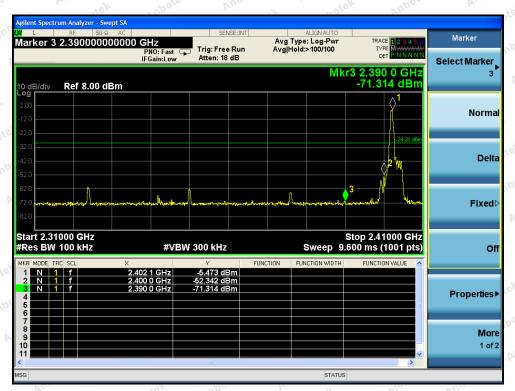
BDR mode



EDR mode



For Non-Hopping Mode



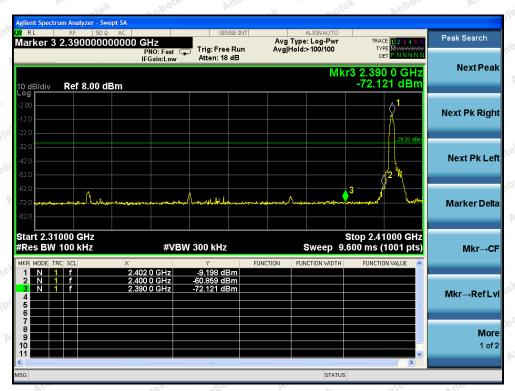
BDR mode -- Lowest



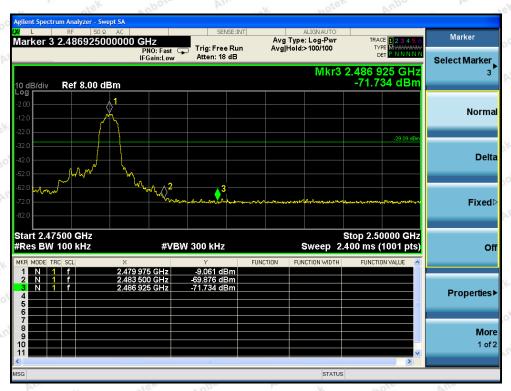
BDR mode -- Highest



For Non-Hopping Mode



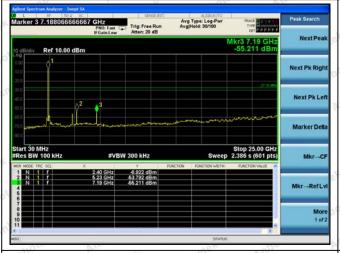
EDR mode -- Lowest



EDR mode -- Highest



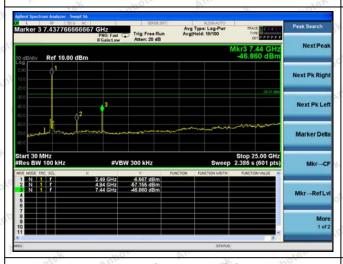
Conducted Emission Method





Test Mode: BDR---Low

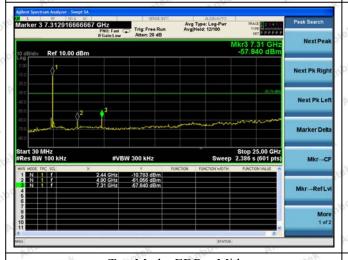
Test Mode: BDR---Mid

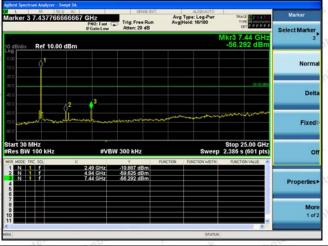




Test Mode: BDR---High

Test Mode: EDR---Low





Test Mode: EDR---Mid

Test Mode: EDR---High



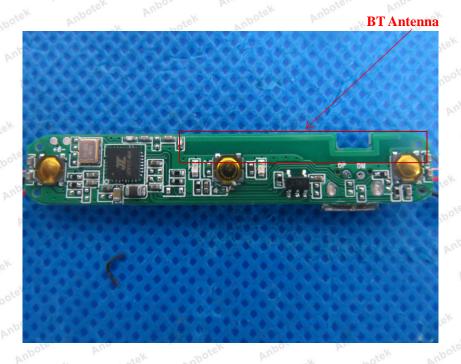
11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
	1) 15.203 requirement:
	An intentional radiator shall be designed to ensure that no antenna other than that furnished
	by the responsible party shall be used with the device. The use of a permanently
	attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the
	manufacturer may design the unit so that a broken antenna can be replaced by the user, but
Requirement	the use of a standard antenna jack or electrical connector is prohibited.
	2) 15.247(c) (1)(i) requirement:
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed
	Point-to-point operations may employ transmitting antennas with directional gain greater
	than 6dBi provided the maximum conducted output power of the intentional radiator is
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The bluetooth antenna is PCB Antenna which permanently attached, and the best case gain of the antenna is 0 dBi. It complies with the standard requirement.





APPENDIX I -- TEST SETUP PHOTOGRAPH

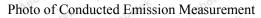




Photo of Radiation Emission Test

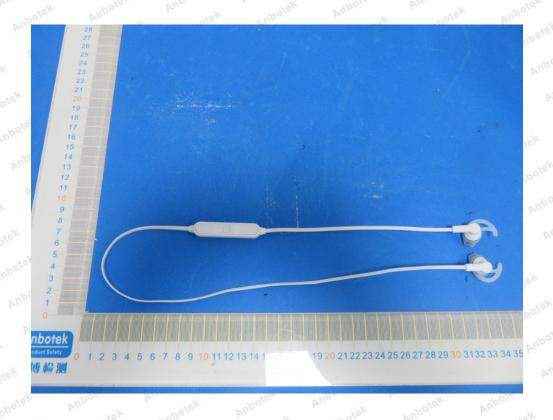


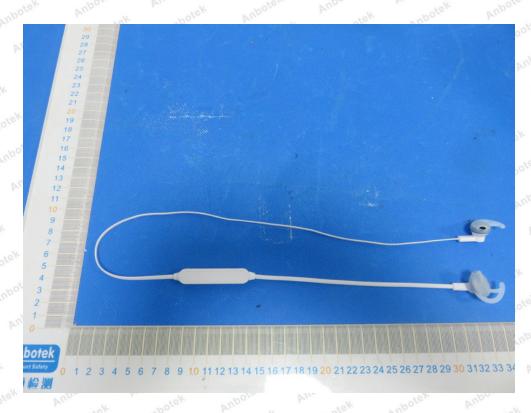






APPENDIX II -- EXTERNAL PHOTOGRAPH





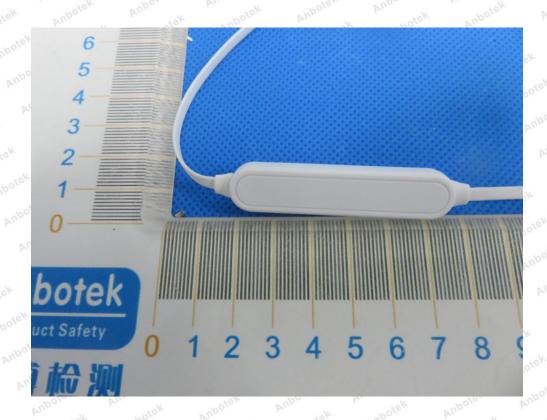




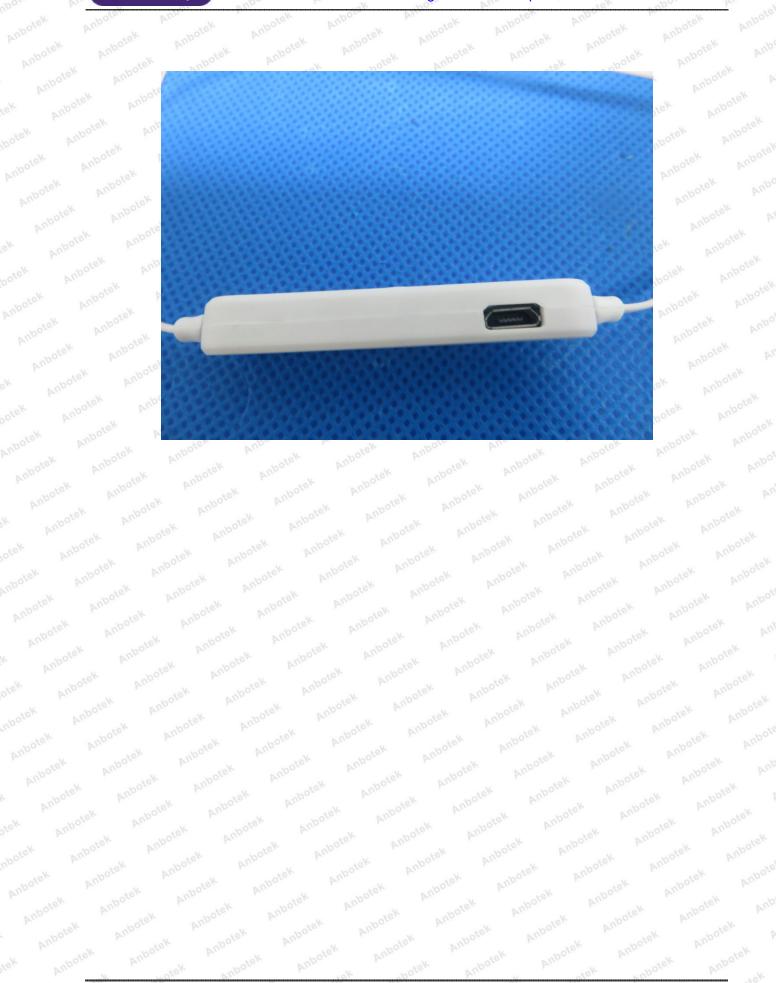












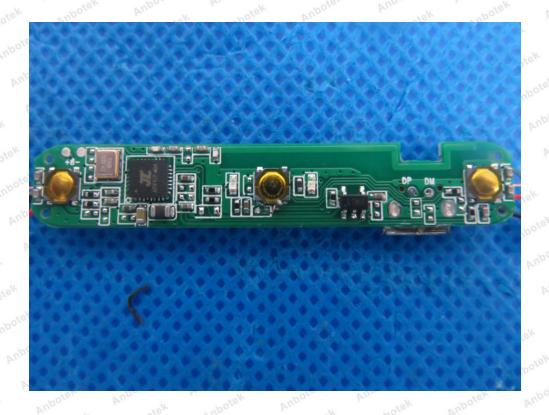


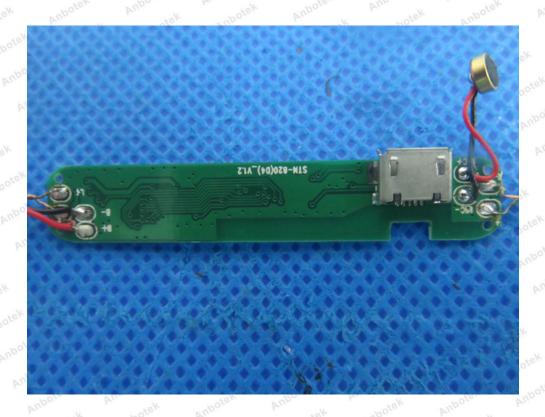
APPENDIX III -- INTERNAL PHOTOGRAPH

















End of report